MCP6421/2/4

4.4 μA/Amplifier, 90 kHz Op Amp

Features:

- Low Quiescent Current:
 - 4.4 µA/amplifier (typical)
- Low Input Offset Voltage:
 - ±1.0 mV (maximum)
- Enhanced EMI Protection:
 - Electromagnetic Interference Rejection Ratio (EMIRR) at 1.8 GHz: 97 dB
- Supply Voltage Range: 1.8V to 5.5V
- Gain Bandwidth Product: 90 kHz (typical)
- · Rail-to-Rail Input/Output
- Slew Rate: 0.05 V/µs (typical)
- · Unity Gain Stable
- · No Phase Reversal
- Small Packages:
 - Singles in SC70-5, SOT-23-5
 - Dual in MSOP-8, SOIC-8
 - Quad in SOIC-14, TSSOP-14
- Extended Temperature Range:
 - -40°C to +125°C

Applications:

- · Portable Medical Instruments
- · Safety Monitoring
- · Battery-Powered Systems
- · Remote Sensing
- · Supply Current Sensing
- Analog Active Filters

Design Aids:

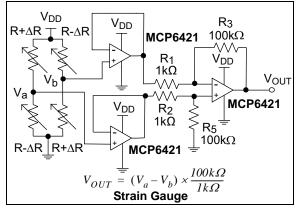
- SPICE Macro Models
- FilterLab[®] Software
- Microchip Advanced Part Selector (MAPS)
- Analog Demonstration and Evaluation Boards
- · Application Notes

Description:

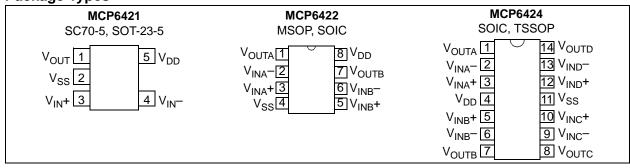
The Microchip Technology Inc. MCP6421/2/4 family of operational amplifiers operate with a single supply voltage as low as 1.8V, while drawing low quiescent current per amplifier (5.5 µA, maximum). This family also has low-input offset voltage (±1.0 mV, maximum) and rail-to-rail input and output operation. In addition, the MCP6421/2/4 family is unity gain stable and has a gain bandwidth product of 90 kHz (typical). This combination of features supports battery-powered and portable applications. The MCP6421/2/4 family has enhanced EMI protection to minimize electromagnetic interference from external sources. This feature makes it well suited for EMI sensitive applications such as power lines, radio stations, and mobile communications, etc.

The MCP6421/2/4 family is offered in single (MCP6421), dual (MCP6422) and quad (MCP6424) packages. All devices are designed using an advanced CMOS process and fully specified in extended temperature range from -40°C to +125°C.

Typical Application



Package Types



MCP6421/2/4

NOTES:

1.0 ELECTRICAL CHARACTERISTICS

1.1 Absolute Maximum Ratings †

V _{DD} – V _{SS}	6.5V
Current at Analog Input Pins (V _{IN} +, V _{IN} -)	±2 mA
Analog Inputs (V _{IN} +, V _{IN} -)††	$V_{SS} - 1.0V$ to $V_{DD} + 1.0V$
All Other Inputs and Outputs	$V_{SS} - 0.3V$ to $V_{DD} + 0.3V$
Difference Input Voltage	V _{DD} – V _{SS}
Output Short-Circuit Current	Continuous
Current at Input Pins	±2 mA
Current at Output and Supply Pins	±30 mA
Storage Temperature	65°C to +150°C
Maximum Junction Temperature (T _J)	+150°C
ESD Protection on All Pins (HBM; MM)	≥ 4 kV; 400V
ESD Protection on All Pins (HBM; MM) (Dual and Quad)	≥ 4 kV; 300V

† Notice: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

†† See Section 4.1.2 "Input Voltage Limits".

1.2 Specifications

TABLE 1-1: DC ELECTRICAL SPECIFICATIONS

Electrical Characteristics : Unless otherwise indicated, T_A = +25°C, V_{DD} = +1.8V to +5.5V, V_{SS} = GND, V_{CM} = V_{DD} /2, V_{OUT} = V_{DD} /2, V_{L} = V_{DD} /2, V_{L} = 100 kΩ to V_{L} and V_{L} = 30 pF (refer to Figure 1-1).									
Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions			
Input Offset									
Input Offset Voltage	Vos	-1.0	_	1.0	mV	$V_{DD} = 3.0V; V_{CM} = V_{DD}/4$			
Input Offset Drift with Temperature	$\Delta V_{OS}/\Delta T_{A}$	_	±3.0	_	μV/°C	T_A = -40°C to +125°C, V_{CM} = V_{SS}			
Power Supply Rejection Ratio	PSRR	75	90	_	dB	$V_{CM} = V_{SS}$			
Input Bias Current and Impedance	e								
Input Bias Current	Ι _Β	_	±1	50	pА				
		_	20	_	pА	$T_A = +85^{\circ}C$			
		_	800	_	рА	T _A = +125°C			
Input Offset Current	Ios	_	±1	_	pА				
Common Mode Input Impedance	Z _{CM}	_	10 ¹³ 12	_	ΩpF				
Differential Input Impedance	Z _{DIFF}	_	10 ¹³ 12	_	Ω∥pF				
Common Mode									
Common Mode Input Voltage Range	V _{CMR}	V _{SS} – 0.3	1	V _{DD} + 0.3	V				
Common Mode Rejection Ratio	CMRR	75	90	_	dB	$V_{DD} = 5.5V$ $V_{CM} = -0.3V$ to 5.8V			
		70	85	_	dB	$V_{DD} = 1.8V$ $V_{CM} = -0.3V$ to 2.1V			

TABLE 1-1: DC ELECTRICAL SPECIFICATIONS (CONTINUED)

Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions			
Open-Loop Gain									
DC Open-Loop Gain (Large Signal)	A _{OL}	95	115	_	dB	$0.3 < V_{OUT} < (V_{DD} - 0.3V)$ $V_{CM} = V_{SS}$ $V_{DD} = 5.5V$			
Output									
High-Level Output Voltage	V _{OH}	V _{DD} – 4	V _{DD} – 1	_	mV	V _{DD} = 1.8V			
		V _{DD} – 5	V _{DD} – 1	_	mV	$V_{DD} = 5.5V$			
Low-Level Output Voltage	V _{OL}	_	V _{SS} + 1	V _{SS} + 4	mV	V _{DD} = 1.8V			
		_	V _{SS} + 1	V _{SS} + 5	mV	$V_{DD} = 5.5V$			
Output Short-Circuit Current	I _{SC}	_	±6	_	mA	V _{DD} = 1.8V			
		_	±22	_	mA	V _{DD} = 5.5V			
Power Supply									
Supply Voltage	V_{DD}	1.8	_	5.5	V				
Quiescent Current per Amplifier	ΙQ	3	4.4	5.5	μA	$I_{O} = 0, V_{CM} = V_{DD}/4$			

TABLE 1-2: AC ELECTRICAL SPECIFICATIONS

Electrical Characteristics: Unless otherwise indicated, $T_A = +25^{\circ}C$, $V_{DD} = +1.8V$ to +5.5V, $V_{SS} = GND$, $V_{CM} = V_{DD}/2$, $V_{CMT} = V_{DD}/2$, $V_{L} = V_{DD}/2$,

$V_{OUT} = V_{DD}/2$, $V_L = V_{DD}/2$, $R_L = 100 \text{ k}\Omega$ to V_L and $C_L = 30 \text{ pF}$ (refer to Figure 1-1).								
Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions		
AC Response								
Gain Bandwidth Product	GBWP	_	90	_	kHz			
Phase Margin	PM	_	55	_	۰	G = +1 V/V		
Slew Rate	SR	_	0.05	_	V/µs			
Noise		•	•	•	•	_		
Input Noise Voltage	E _{ni}	_	15		μV _{P-P}	f = 0.1 Hz to 10 Hz		
Input Noise Voltage Density	e _{ni}	_	95	1	nV/√Hz	f = 1 kHz		
		_	90	_	nV/√Hz	f = 10 kHz		
Input Noise Current Density	i _{ni}	_	0.6	_	fA/√Hz	f = 1 kHz		
Electromagnetic Interference Rejection Ratio	EMIRR	_	77	_	dB	V _{IN} = 100 mV _{PK} , 400 MHz		
		_	92	_		V _{IN} = 100 mV _{PK} , 900 MHz		
		_	97	_		V _{IN} = 100 mV _{PK} , 1800 MHz		
		_	99	_		V _{IN} = 100 mV _{PK} , 2400 MHz		

Electrical Characteristics: Unless otherwise indicated, $V_{DD} = +1.8V$ to +5.5V and $V_{SS} = GND$.								
Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions		
Temperature Ranges								
Operating Temperature Range	T _A	-40	_	+125	°C	Note 1		
Storage Temperature Range	T _A	-65	_	+150	°C			
Thermal Package Resistances								
Thermal Resistance, 5L-SC70	θ_{JA}	_	331	_	°C/W			
Thermal Resistance, 5L-SOT-23	θ_{JA}	_	221	_	°C/W			
Thermal Resistance, 8L-MSOP	θ_{JA}	_	211	_	°C/W			

TABLE 1-3: TEMPERATURE SPECIFICATIONS

Note 1: The internal junction temperature (T_J) must not exceed the absolute maximum specification of +150°C.

150

95

100

 θ_{JA}

 θ_{JA}

 θ_{JA}

1.3 Test Circuits

Thermal Resistance, 8L-SOIC

Thermal Resistance, 14L-SOIC

Thermal Resistance, 14L-TSSOP

The circuit used for most DC and AC tests is shown in Figure 1-1. This circuit can independently set V_{CM} and V_{OUT} (see Equation 1-1). Note that V_{CM} is not the circuit's Common mode voltage ((V $_{\rm P}$ + V $_{\rm M}$)/2), and that V_{OST} includes V_{OS} plus the effects (on the input offset error, V_{OST}) of the temperature, CMRR, PSRR and A_{OL} .

EQUATION 1-1:

$$G_{DM} = R_F/R_G$$

$$V_{CM} = (V_P + V_{DD}/2)/2$$

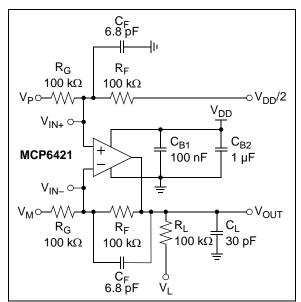
$$V_{OST} = V_{IN-} - V_{IN+}$$

$$V_{OUT} = (V_{DD}/2) + (V_P - V_M) + V_{OST}(I + G_{DM})$$
Where:
$$G_{DM} = \text{Differential Mode Gain} \qquad (V/V)$$

$$V_{CM} = \text{Op Amp's Common Mode} \qquad (V)$$

$$Input Voltage$$

$$V_{OST} = \text{Op Amp's Total Input Offset Voltage} \qquad (mV)$$



°C/W

°C/W

°C/W

FIGURE 1-1: AC and DC Test Circuit for Most Specifications.

MCP6421/2/4

NOTES:

2.0 TYPICAL PERFORMANCE CURVES

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

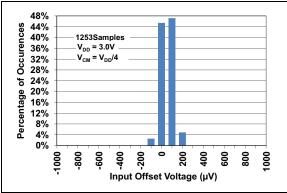


FIGURE 2-1: Input Offset Voltage.

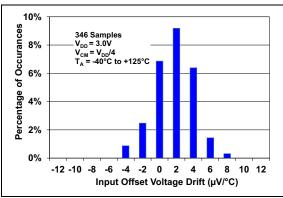


FIGURE 2-2: Input Offset Voltage Drift.

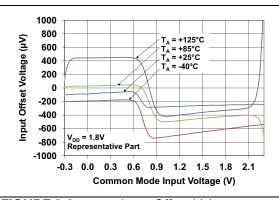


FIGURE 2-3: Input Offset Voltage vs. Common Mode Input Voltage.

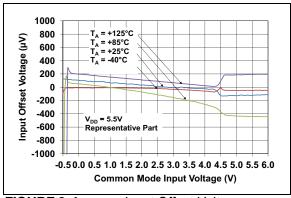


FIGURE 2-4: Input Offset Voltage vs. Common Mode Input Voltage.

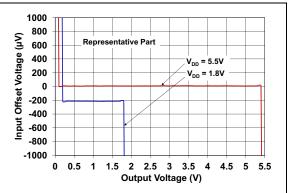


FIGURE 2-5: Input Offset Voltage vs. Output Voltage.

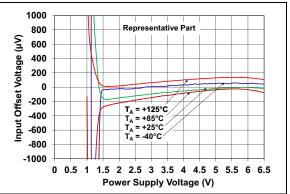


FIGURE 2-6: Input Offset Voltage vs. Power Supply Voltage.

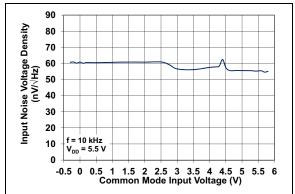


FIGURE 2-7: Input Noise Voltage Density vs. Common Mode Input Voltage.

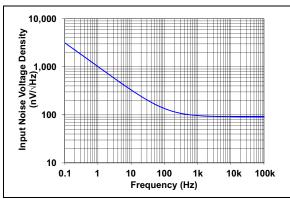


FIGURE 2-8: Input Noise Voltage Density vs. Frequency.

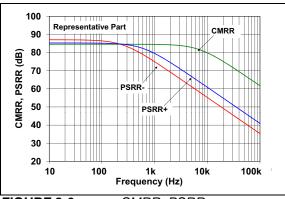


FIGURE 2-9: CMRR, PSRR vs. Frequency.

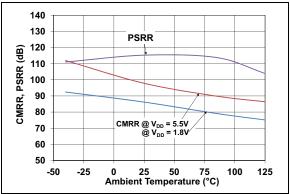


FIGURE 2-10: CMRR, PSRR vs. Ambient Temperature.

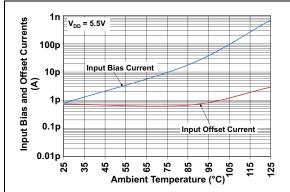


FIGURE 2-11: Input Bias, Offset Current vs. Ambient Temperature.

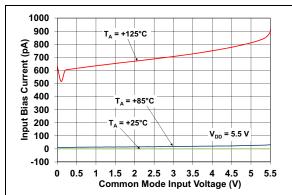


FIGURE 2-12: Input Bias Current vs. Common Mode Input Voltage.

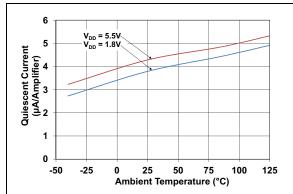


FIGURE 2-13: Quiescent Current vs. Ambient Temperature.

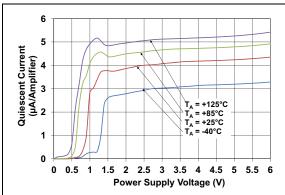


FIGURE 2-14: Quiescent Current vs. Power Supply Voltage.

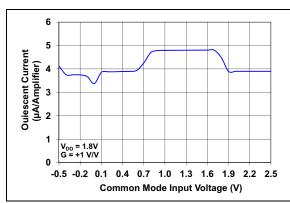


FIGURE 2-15: Quiescent Current vs. Common Mode Input Voltage.

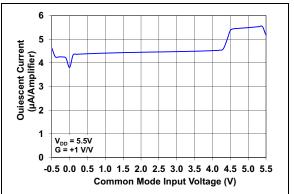


FIGURE 2-16: Quiescent Current vs. Common Mode Input Voltage.

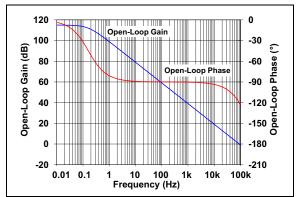


FIGURE 2-17: Open-Loop Gain, Phase vs. Frequency.

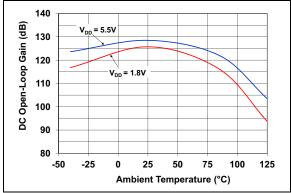


FIGURE 2-18: DC Open-Loop Gain vs. Ambient Temperature.

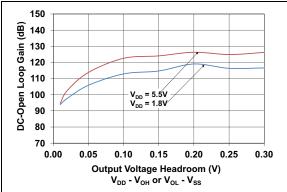


FIGURE 2-19: DC Open-Loop Gain vs. Output Voltage Headroom.

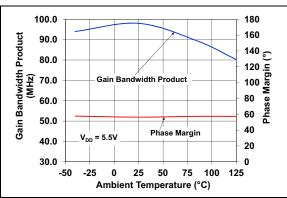


FIGURE 2-20: Gain Bandwidth Product, Phase Margin vs. Ambient Temperature.

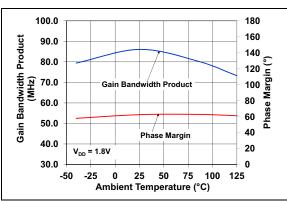


FIGURE 2-21: Gain Bandwidth Product, Phase Margin vs. Ambient Temperature.

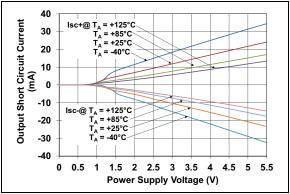


FIGURE 2-22: Output Short Circuit Current vs. Power Supply Voltage.

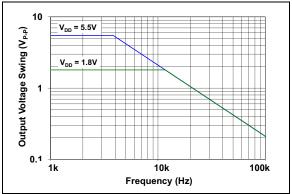


FIGURE 2-23: Output Voltage Swing vs. Frequency.

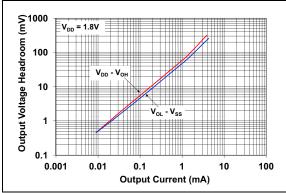


FIGURE 2-24: Output Voltage Headroom vs. Output Current.

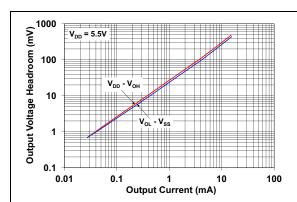


FIGURE 2-25: Output Voltage Headroom vs. Output Current.

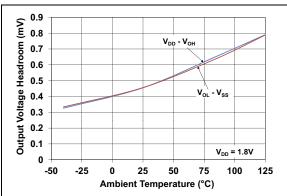


FIGURE 2-26: Output Voltage Headroom vs. Ambient Temperature.

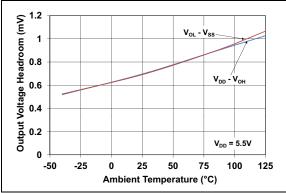


FIGURE 2-27: Output Voltage Headroom vs. Ambient Temperature.

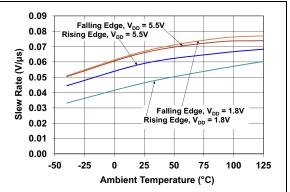


FIGURE 2-28: Slew Rate vs. Ambient Temperature.

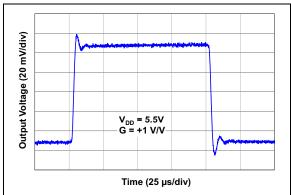


FIGURE 2-29: Small Signal Non-Inverting Pulse Response.

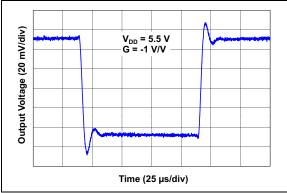


FIGURE 2-30: Small Signal Inverting Pulse Response.

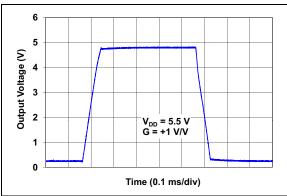


FIGURE 2-31: Large Signal Non-Inverting Pulse Response.

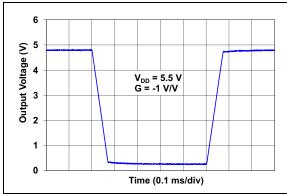


FIGURE 2-32: Large Signal Inverting Pulse Response.

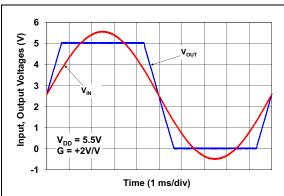


FIGURE 2-33: The MCP6421/2/4 Device Shows No Phase Reversal.

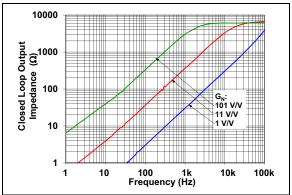


FIGURE 2-34: Closed Loop Output Impedance vs. Frequency.

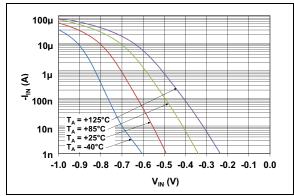


FIGURE 2-35: Measured Input Current vs. Input Voltage (below V_{SS}).

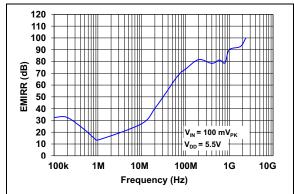


FIGURE 2-36: EMIRR vs. Frequency.

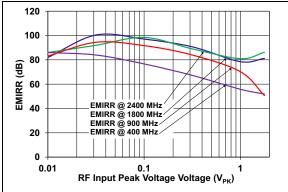


FIGURE 2-37: EMIRR vs. RF Input Peak-to-Peak Voltage.

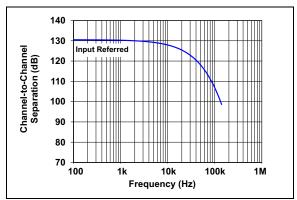


FIGURE 2-38: Channel-to-Channel Separation vs. Frequency.

MCP6421/2/4

NOTES:

3.0 PIN DESCRIPTIONS

Descriptions of the pins are listed in Table 3-1.

TABLE 3-1: PIN FUNCTION TABLE

MCP6421	MCP6422	MCP6424		
SC70-5, SOT-23-5	MSOP, SOIC	SOIC, TSSOP	Symbol	Description
1	1	1	V _{OUT} , V _{OUTA}	Analog Output (op amp A)
4	2	2	V _{IN} -, V _{INA} -	Inverting Input (op amp A)
3	3	3	V _{IN} +, V _{INA} +	Non-inverting Input (op amp A)
5	8	4	V _{DD}	Positive Power Supply
_	5	5	V _{INB} +	Non-inverting Input (op amp B)
_	6	6	V _{INB} -	Inverting Input (op amp B)
_	7	7	V _{OUTB}	Analog Output (op amp B)
_	_	8	V _{outc}	Analog Output (op amp C)
_	_	9	V _{INC} -	Inverting Input (op amp C)
_	_	10	V _{INC} +	Non-inverting Input (op amp C)
2	4	11	V _{SS}	Negative Power Supply
	_	12	V _{IND} +	Non-inverting Input (op amp D)
_	_	13	V _{IND} -	Inverting Input (op amp D)
_	_	14	V _{OUTD}	Analog Output (op amp D)

3.1 Analog Outputs

The output pin is a low-impedance voltage source.

3.2 Analog Inputs

The non-inverting and inverting inputs are high-impedance CMOS inputs with low bias currents.

3.3 Power Supply Pins (V_{SS}, V_{DD})

The positive power supply (V_{DD}) is 1.8V to 5.5V higher than the negative power supply (V_{SS}). For normal operation, the other pins are at voltages between V_{SS} and V_{DD} .

Typically, these parts are used in a single (positive) supply configuration. In this case, V_{SS} is connected to ground and V_{DD} is connected to the supply. V_{DD} will need bypass capacitors.

MCP6421/2/4

NOTES:

4.0 APPLICATION INFORMATION

The MCP6421/2/4 op amps are manufactured using Microchip's state-of-the-art CMOS process. This op amp is unity gain stable and suitable for a wide range of general purpose applications.

4.1 Rail-to-Rail Input

4.1.1 PHASE REVERSAL

The MCP6421/2/4 op amps are designed to prevent phase reversal, when the input pins exceed the supply voltages. Figure 2-33 shows the input voltage exceeding the supply voltage with no phase reversal.

4.1.2 INPUT VOLTAGE LIMITS

In order to prevent damage and/or improper operation of the amplifier, the circuit must limit the voltages at the input pins (see **Section 1.1**, **Absolute Maximum Ratings**†).

The Electrostatic Discharge (ESD) protection on the inputs can be depicted as shown in Figure 4-1. This structure was chosen to protect the input transistors against many, but not all, over-voltage conditions, and to minimize the input bias current (I_B).

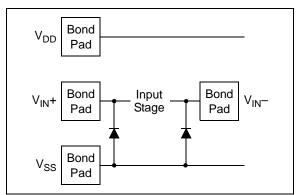


FIGURE 4-1: Simplified Analog Input ESD Structures.

The input ESD diodes clamp the inputs when they try to go more than one diode drop below V_{SS} . They also clamp any voltages that go well above V_{DD} ; their breakdown voltage is high enough to allow normal operation, but not low enough to protect against slow over-voltage (beyond V_{DD}) events. Very fast ESD events that meet the spec are limited so that damage does not occur.

In some applications, it may be necessary to prevent excessive voltages from reaching the op amp inputs; Figure 4-2 shows one approach to protecting these inputs.

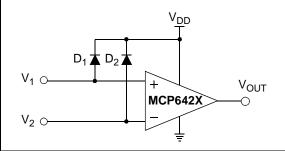


FIGURE 4-2: Protecting the Analog Inputs.

A significant amount of current can flow out of the inputs when the Common mode voltage (V_{CM}) is below ground (V_{SS}); see Figure 2-35.

4.1.3 INPUT CURRENT LIMITS

In order to prevent damage and/or improper operation of the amplifier, the circuit must limit the currents into the input pins (see Section 1.1, Absolute Maximum Ratings †).

Figure 4-3 shows one approach to protecting these inputs. The resistors R_1 and R_2 limit the possible currents in or out of the input pins (and the ESD diodes, D_1 and D_2). The diode currents will go through either V_{DD} or V_{SS} .

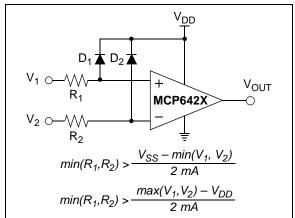


FIGURE 4-3: Protecting the Analog Inputs.

4.1.4 NORMAL OPERATION

The input stage of the MCP6421/2/4 op amps uses two differential input stages in parallel. One operates at a low Common mode input voltage (V_{CM}), while the other operates at a high V_{CM}. With this topology, the device operates with a V_{CM} up to 300 mV above V_{DD} and 300 mV below V_{SS}. The input offset voltage is measured at V_{CM} = V_{SS} – 0.3V and V_{DD} + 0.3V, to ensure proper operation.

The transition between the input stages occurs when V_{CM} is near $V_{DD} - 0.6V$ (see Figures 2-3 and 2-4). For the best distortion performance and gain linearity, with non-inverting gains, avoid this region of operation.

4.2 Rail-to-Rail Output

The output voltage range of the MCP6421/2/4 op amps is 0.001V (typical) and 5.499V (typical) when $R_L=100~k\Omega$ is connected to $V_{DD}/2$ and $V_{DD}=5.5V.$ Refer to Figures 2-24 and 2-26 for more information.

4.3 Capacitive Loads

Driving large capacitive loads can cause stability problems for voltage feedback op amps. As the load capacitance increases, the feedback loop's phase margin decreases, and the closed-loop bandwidth is reduced. This produces gain peaking in the frequency response, with overshoot and ringing in the step response. While a unity-gain buffer (G = +1 V/V) is the most sensitive to the capacitive loads, all gains show the same general behavior.

When driving large capacitive loads with the MCP6421/2/4 op amps (e.g., >60 pF when G = +1 V/V), a small series resistor at the output (R $_{\rm ISO}$ in Figure 4-5) improves the feedback loop's phase margin (stability) by making the output load resistive at higher frequencies. The bandwidth will be generally lower than the bandwidth with no capacitance load.

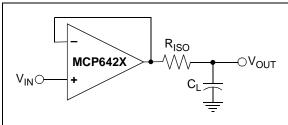


FIGURE 4-4: Output Resistor, R_{ISO} Stabilizes Large Capacitive Loads.

Figure 4-5 gives the recommended R_{ISO} values for the different capacitive loads and gains. The x-axis is the normalized load capacitance (C_L/G_N), where G_N is the circuit's noise gain. For non-inverting gains, G_N and the Signal Gain are equal. For inverting gains, G_N is 1+|Signal Gain| (e.g., -1 V/V gives G_N = +2 V/V).

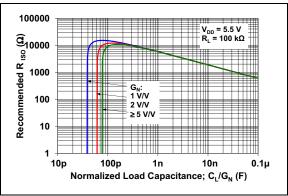


FIGURE 4-5: Recommended R_{ISO} Values for Capacitive Loads.

After selecting R_{ISO} for your circuit, double-check the resulting frequency response peaking and step response overshoot. Modify R_{ISO} 's value until the response is reasonable. Bench evaluation and simulations with the MCP6421/2/4 SPICE macro model are very helpful.

4.4 Supply Bypass

The MCP6421/2/4 op amps' power supply pin (V_{DD} for single-supply) should have a local bypass capacitor (i.e., 0.01 μ F to 0.1 μ F) within 2 mm for good high frequency performance. It can use a bulk capacitor (i.e., 1 μ F or larger) within 100 mm to provide large, slow currents. This bulk capacitor can be shared with other analog parts.

4.5 Unused Op Amps

An unused op amp in a quad package (MCP6424) should be configured as shown in Figure 4-6. These circuits prevent the output from toggling and causing crosstalk. Circuit A sets the op amp at its minimum noise gain. The resistor divider produces any desired reference voltage within the output voltage range of the op amp, and the op amp buffers that reference voltage.

Circuit B uses the minimum number of components and operates as a comparator, but it may draw more current.

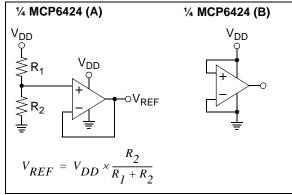


FIGURE 4-6:

Unused Op Amps.

4.6 PCB Surface Leakage

In applications where low input bias current is critical, Printed Circuit Board (PCB) surface leakage effects need to be considered. Surface leakage is caused by humidity, dust or other contamination on the board. Under low humidity conditions, a typical resistance between nearby traces is $10^{12}\Omega$. A 5V difference would cause 5 pA of current to flow, which is greater than the MCP6421/2/4 family's bias current at +25°C (±1 pA, typical).

The easiest way to reduce surface leakage is to use a guard ring around sensitive pins (or traces). The guard ring is biased at the same voltage as the sensitive pin. An example of this type of layout is shown in Figure 4-7.

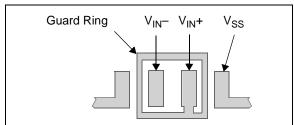


FIGURE 4-7: Example Guard Ring Layout for Inverting Gain.

- 1. Non-inverting Gain and Unity-Gain Buffer:
 - a) Connect the non-inverting pin (V_{IN}+) to the input with a wire that does not touch the PCB surface.
 - b) Connect the guard ring to the inverting input pin (V_{IN}-). This biases the guard ring to the Common mode input voltage.
- Inverting Gain and Transimpedance Gain Amplifiers (convert current to voltage, such as photo detectors):
 - a) Connect the guard ring to the non-inverting input pin (V_{IN} +). This biases the guard ring to the same reference voltage as the op amp (e.g., $V_{DD}/2$ or ground).
 - b) Connect the inverting pin (V_{IN}-) to the input with a wire that does not touch the PCB surface.

4.7 Electromagnetic Interference Rejection Ratio (EMIRR) Definitions

The electromagnetic interference (EMI) is the disturbance that affects an electrical circuit due to either electromagnetic induction or electromagnetic radiation emitted from an external source.

The parameter which describes the EMI robustness of an op amp is the Electromagnetic Interference Rejection Ratio (EMIRR). It quantitatively describes the effect that an RF interfering signal has on op amp performance. Internal passive filters make EMIRR better compared with older parts. This means that, with good PCB layout techniques, your EMC performance should be better.

EMIRR is defined as:

EQUATION 4-1:

$$EMIRR(dB) = 20 \bullet log(\frac{V_{RF}}{\Delta V_{OS}})$$

Where:

V_{RF} = Peak Amplitude of

RF Interfering Signal (V_{PK})

 ΔV_{OS} = Input Offset Voltage Shift (V)

4.8 Application Circuits

4.8.1 CARBON MONOXIDE GAS SENSOR

A carbon monoxide (CO) gas detector is a device which detects the presence of carbon monoxide gas level. Usually this is battery powered and transmits audible and visible warnings.

The sensor responds to CO gas by reducing its resistance proportionally to the amount of CO present in the air exposed to the internal element. On the sensor module, this variable is part of a voltage divider formed by the internal element and potentiometer R_1 . The output of this voltage divider is fed into the non-inverting inputs of the MCP6421 op amp. The device is configured as a buffer with unity gain and is used to provide a non-loaded test point for sensor sensitivity.

Because this sensor can be corrupted by parasitic electromagnetic signals, the MCP6421 op amp can be used for conditioning this sensor.

In Figure 4-8, the variable resistor is used to calibrate the sensor in different environments.

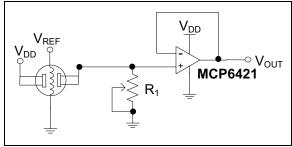


FIGURE 4-8:

CO Gas Sensor Circuit.

4.8.2 PRESSURE SENSOR AMPLIFIER

The MCP6421/2/4 op amps are well suited for conditioning sensor signals in battery-powered applications. Many sensors are configured as Wheatstone bridges. Strain gauges and pressure sensors are two common examples.

Figure 4-9 shows a strain gauge amplifier, using the MCP6421/2/4 Enhanced EMI protection device. The difference amplifier with EMI robustness op amp is used to amplify the signal from the Wheatstone bridge. The two op amps, configured as buffers and connected at outputs of pressure sensors, prevents resistive loading of the bridge by resistor R1 and R2. Resistors R_1,R_2 and R_3,R_5 need to be chosen with very low tolerance to match the CMRR.

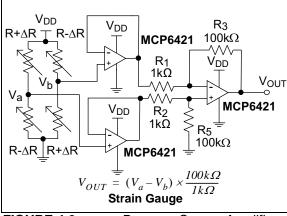


FIGURE 4-9:

Pressure Sensor Amplifier.

4.8.3 BATTERY CURRENT SENSING

The MCP6421/2/4 op amps' Common Mode Input Range, which goes 0.3V beyond both supply rails, supports their use in high-side and low-side battery current sensing applications. The low quiescent current helps prolong battery life, and the rail-to-rail output supports detection of low currents.

Figure 4-10 shows a high side battery current sensor circuit. The 10Ω resistor is sized to minimize power losses. The battery current (I_DD) through the 10Ω resistor causes its top terminal to be more negative than the bottom terminal. This keeps the Common mode input voltage of the op amp below V_DD, which is within its allowed range. The output of the op amp will also be below V_DD, within its Maximum Output Voltage Swing specification.

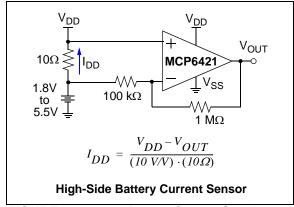


FIGURE 4-10: Battery Current Sensing.

5.0 DESIGN AIDS

Microchip provides the basic design tools needed for the MCP6421/2/4 op amps.

5.1 SPICE Macro Model

The latest SPICE macro model for the MCP6421/2/4 op amp is available on the Microchip web site at www.microchip.com. The model was written and tested in the official OrCAD (Cadence®) owned PSpice®. For the other simulators, translation may be required.

The model covers a wide aspect of the op amp's electrical specifications. Not only does the model cover voltage, current and resistance of the op amp, but it also covers the temperature and the noise effects on the behavior of the op amp. The model has not been verified outside of the specification range listed in the op amp data sheet. The model behaviors under these conditions cannot ensure it will match the actual op amp performance.

Moreover, the model is intended to be an initial design tool. Bench testing is a very important part of any design and cannot be replaced with simulations. Also, simulation results using this macro model need to be validated by comparing them to the data sheet specifications and characteristic curves.

5.2 FilterLab® Software

Microchip's FilterLab software is an innovative software tool that simplifies analog active filter design using op amps. Available at no cost from the Microchip web site at www.microchip.com/filterlab, the FilterLab design tool provides full schematic diagrams of the filter circuit with component values. It also outputs the filter circuit in SPICE format, which can be used with the macro model to simulate the actual filter performance.

5.3 Microchip Advanced Part Selector (MAPS)

MAPS is a software tool that helps semiconductor professionals efficiently identify the Microchip devices that fit a particular design requirement. Available at no website Microchip cost from the www.microchip.com/ maps, the MAPS is an overall selection tool for Microchip's product portfolio that includes Analog, Memory, MCUs and DSCs. Using this tool, you can define a filter to sort features for a parametric search of devices and export side-by-side technical comparison reports. Helpful links are also provided for data sheets, purchase and sampling of Microchip parts.

5.4 Analog Demonstration and Evaluation Boards

Microchip offers a broad spectrum of Analog Demonstration and Evaluation Boards that are designed to help you achieve faster time to market. For a complete listing of these boards and their corresponding user's guides and technical information, visit the Microchip web site at www.microchip.com/analogtools.

Some boards that are especially useful are:

- MCP6XXX Amplifier Evaluation Board 1
- MCP6XXX Amplifier Evaluation Board 2
- MCP6XXX Amplifier Evaluation Board 3
- MCP6XXX Amplifier Evaluation Board 4
- · Active Filter Demo Board Kit
- 5/6-Pin SOT-23 Evaluation Board, P/N VSUPEV2

5.5 Application Notes

The following Microchip Analog Design Note and Application Notes are available on the Microchip web site at www.microchip.com/appnotes, and are recommended as supplemental reference resources.

- ADN003 "Select the Right Operational Amplifier for your Filtering Circuits", DS21821
- AN722 "Operational Amplifier Topologies and DC Specifications", DS00722
- AN723 "Operational Amplifier AC Specifications and Applications", DS00723
- AN884 "Driving Capacitive Loads With Op Amps", DS00884
- AN990 "Analog Sensor Conditioning Circuits An Overview", DS00990
- AN1177 "Op Amp Precision Design: DC Errors", DS01177
- AN1228 "Op Amp Precision Design: Random Noise", DS01228
- AN1297 "Microchip's Op Amp SPICE Macro Models", DS01297
- AN1332: "Current Sensing Circuit Concepts and Fundamentals" DS01332
- AN1494: "Using MCP6491 Op Amps for Photodetection Applications" DS01494

These application notes and others are listed in the design guide:

• "Signal Chain Design Guide", DS21825

MCP6421/2/4

NOTES:

6.0 PACKAGING INFORMATION

6.1 Package Marking Information

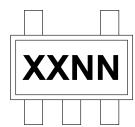
5-Lead SC70 (MCP6421 only)

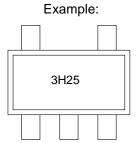


Example:

DS25

5-Lead SOT-23 (MCP6421 only)





8-Lead MSOP (3x3 mm) (MCP6422 only)





Legend: XX...X Customer-specific information

Y Year code (last digit of calendar year)
YY Year code (last 2 digits of calendar year)
WW Week code (week of January 1 is week '01')

NNN Alphanumeric traceability code

e3 Pb-free JEDEC designator for Matte Tin (Sn)

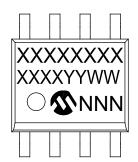
This package is Pb-free. The Pb-free JEDEC designator (@3)

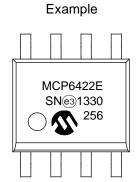
can be found on the outer packaging for this package.

Note: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line, thus limiting the number of available characters for customer-specific information.

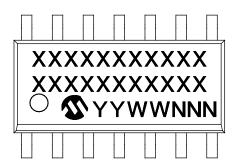
MCP6421/2/4

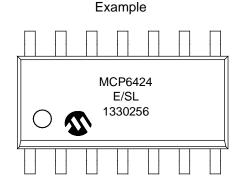
8-Lead SOIC (150 mil.) (MCP6422 only)



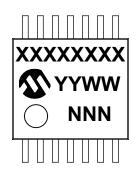


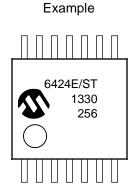
14-Lead SOIC (3.90 mm) (MCP6424 only)





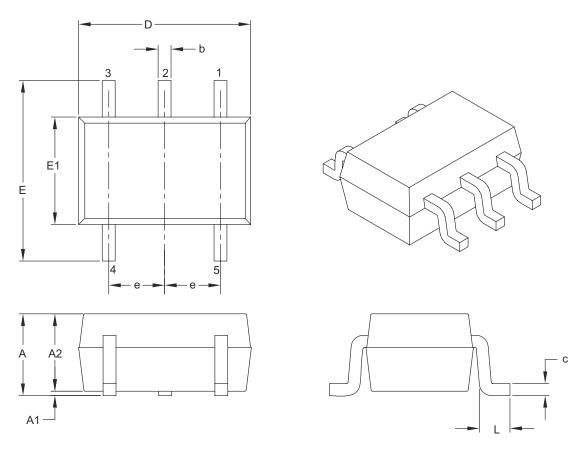
14-Lead TSSOP (4.4 mm) (MCP6424 only)





5-Lead Plastic Small Outine Transistor (LTY) [SC70]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	U	Jnits	1	MILLIMETERS	3
	Dimension Li	mits	MIN	NOM	MAX
Number of Pins		N		5	
Pitch		е		0.65 BSC	
Overall Height		Α	0.80	_	1.10
Molded Package Thickness	,	A2	0.80	_	1.00
Standoff	,	A1	0.00	_	0.10
Overall Width		E	1.80	2.10	2.40
Molded Package Width	E	E1	1.15	1.25	1.35
Overall Length		D	1.80	2.00	2.25
Foot Length		L	0.10	0.20	0.46
Lead Thickness		С	0.08	_	0.26
Lead Width		b	0.15	_	0.40

Notes

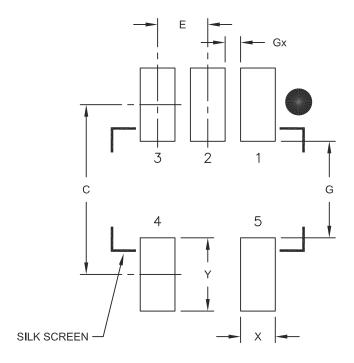
- 1. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.127 mm per side.
- 2. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-061B

5-Lead Plastic Small Outine Transistor (LTY) [SC70]

lote: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

	Units			S
Dimension	Dimension Limits		NOM	MAX
Contact Pitch	E	0.65 BSC		
Contact Pad Spacing	С		2.20	
Contact Pad Width	Х			0.45
Contact Pad Length	Υ			0.95
Distance Between Pads	G	1.25		
Distance Between Pads	Gx	0.20		

Notes:

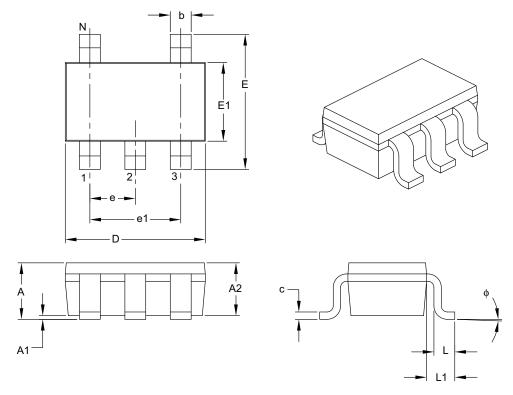
1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2061A

5-Lead Plastic Small Outline Transistor (OT) [SOT-23]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units	3	MILLIMETERS	3
	Dimension Limits	MIN	NOM	MAX
Number of Pins	N		5	
Lead Pitch	е		0.95 BSC	
Outside Lead Pitch	e1		1.90 BSC	
Overall Height	A	0.90	_	1.45
Molded Package Thickness	A2	0.89	_	1.30
Standoff	A1	0.00	_	0.15
Overall Width	E	2.20	_	3.20
Molded Package Width	E1	1.30	_	1.80
Overall Length	D	2.70	_	3.10
Foot Length	L	0.10	_	0.60
Footprint	L1	0.35	_	0.80
Foot Angle	ф	0°	_	30°
Lead Thickness	С	0.08	_	0.26
Lead Width	b	0.20	_	0.51

Notes:

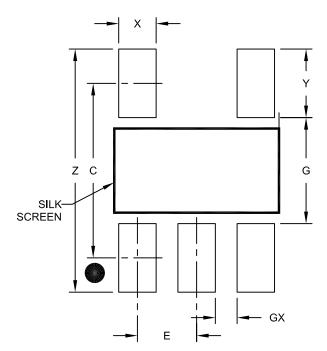
- 1. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.127 mm per side.
- 2. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-091B

5-Lead Plastic Small Outline Transistor (OT) [SOT-23]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

	MILLIMETERS			
Dimension Limits		MIN	NOM	MAX
Contact Pitch	Е	0.95 BSC		
Contact Pad Spacing	С		2.80	
Contact Pad Width (X5)	Х			0.60
Contact Pad Length (X5)	Υ			1.10
Distance Between Pads	G	1.70		
Distance Between Pads	GX	0.35		
Overall Width	Z			3.90

Notes

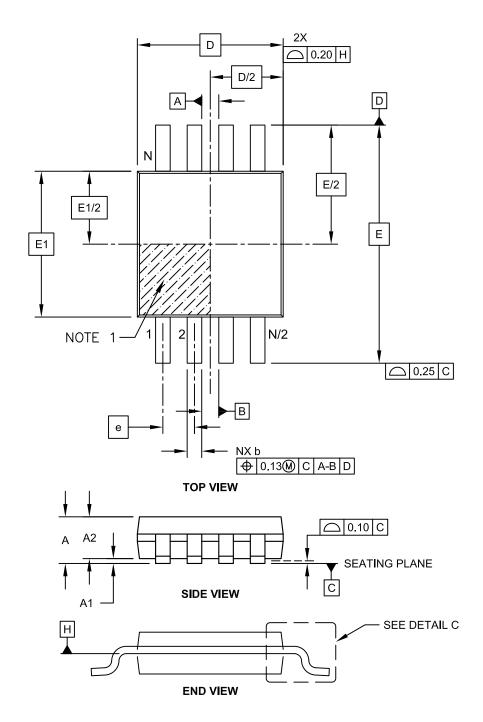
1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2091A

8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

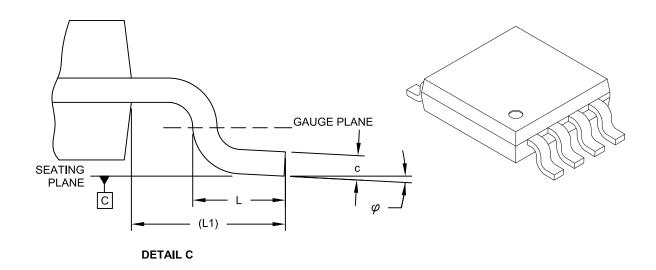
Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



Microchip Technology Drawing C04-111C Sheet 1 of 2

8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	MILLIMETERS				
Dimension	Limits	MIN	NOM	MAX	
Number of Pins	N		8		
Pitch	е		0.65 BSC		
Overall Height	Α	-	-	1.10	
Molded Package Thickness	A2	0.75	0.85	0.95	
Standoff	A1	0.00	-	0.15	
Overall Width	Е	4.90 BSC			
Molded Package Width	E1	3.00 BSC			
Overall Length	D	3.00 BSC			
Foot Length	L	0.40	0.60	0.80	
Footprint	L1	0.95 REF			
Foot Angle	φ	0°	-	8°	
Lead Thickness	С	0.08	-	0.23	
Lead Width	b	0.22	-	0.40	

Notes:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm per side.
- 3. Dimensioning and tolerancing per ASME Y14.5M.

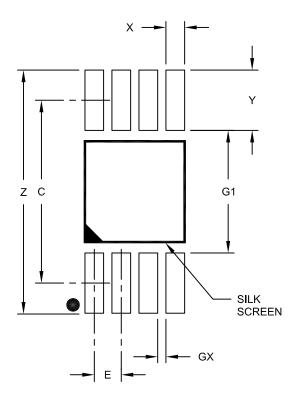
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-111C Sheet 2 of 2

8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

ote: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

	MILLIMETERS			
Dimension	Dimension Limits		NOM	MAX
Contact Pitch	Е	0.65 BSC		
Contact Pad Spacing	С		4.40	
Overall Width	Z			5.85
Contact Pad Width (X8)	X1			0.45
Contact Pad Length (X8)	Y1			1.45
Distance Between Pads	G1	2.95		
Distance Between Pads	GX	0.20		

Notes:

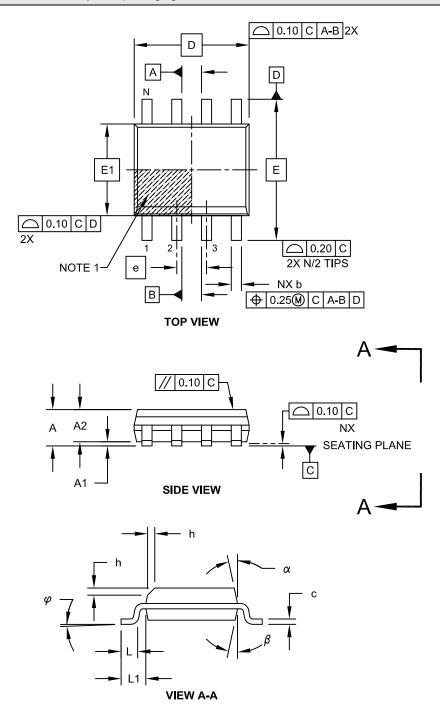
1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2111A

8-Lead Plastic Small Outline (SN) - Narrow, 3.90 mm Body [SOIC]

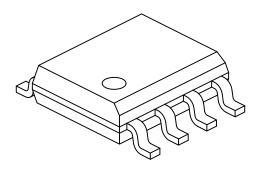
Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



Microchip Technology Drawing No. C04-057C Sheet 1 of 2

8-Lead Plastic Small Outline (SN) - Narrow, 3.90 mm Body [SOIC]

lote: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units		MILLIMETERS		
Dimension Limits		MIN	NOM	MAX	
Number of Pins	N		8		
Pitch	е		1.27 BSC		
Overall Height	Α	i	ı	1.75	
Molded Package Thickness	A2	1.25	į	=	
Standoff §	A1	0.10	ı	0.25	
Overall Width	Е	6.00 BSC			
Molded Package Width	E1	3.90 BSC			
Overall Length	D	4.90 BSC			
Chamfer (Optional)	h	0.25	İ	0.50	
Foot Length	L	0.40	ı	1.27	
Footprint	L1	1.04 REF			
Foot Angle	φ	0°	į	8°	
Lead Thickness	С	0.17 - 0.25			
Lead Width	b	0.31	ı	0.51	
Mold Draft Angle Top	α	5°	-	15°	
Mold Draft Angle Bottom	β	5°	-	15°	

Notes:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. § Significant Characteristic
- 3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm per side.
- 4. Dimensioning and tolerancing per ASME Y14.5M $\,$

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

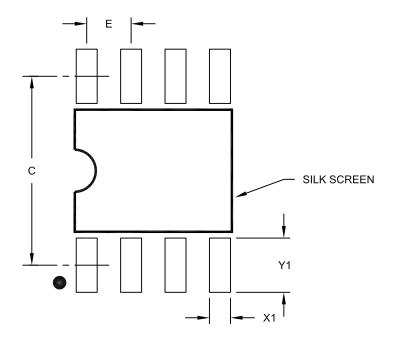
REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing No. C04-057C Sheet 2 of 2

Note:

8-Lead Plastic Small Outline (SN) - Narrow, 3.90 mm Body [SOIC]

For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

	Units	MILLIMETERS		
Dimension Limits		MIN	NOM	MAX
Contact Pitch	E		1.27 BSC	
Contact Pad Spacing	С		5.40	
Contact Pad Width (X8)	X1			0.60
Contact Pad Length (X8)	Y1			1.55

Notes:

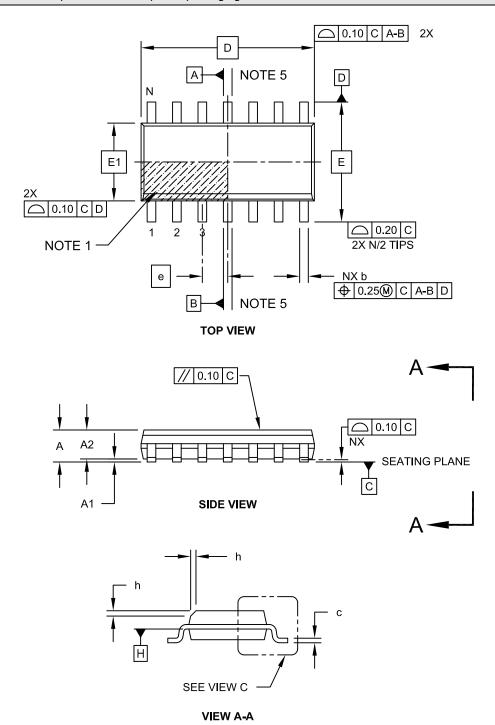
1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2057A

14-Lead Plastic Small Outline (SL) - Narrow, 3.90 mm Body [SOIC]

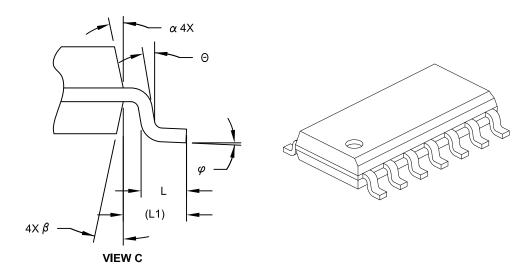
Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



Microchip Technology Drawing No. C04-065C Sheet 1 of 2

14-Lead Plastic Small Outline (SL) - Narrow, 3.90 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units		MILLIMETERS		
Dimension Limits		MIN	NOM	MAX	
Number of Pins	N	14			
Pitch	е		1.27 BSC		
Overall Height	Α	-	-	1.75	
Molded Package Thickness	A2	1.25	ı	-	
Standoff §	A1	0.10	-	0.25	
Overall Width	Е	6.00 BSC			
Molded Package Width	E1	3.90 BSC			
Overall Length	D	8.65 BSC			
Chamfer (Optional)	h	0.25 - 0.50			
Foot Length	L	0.40	-	1.27	
Footprint	L1	1.04 REF			
Lead Angle	Θ	0°	-	-	
Foot Angle	φ	0° - 8°			
Lead Thickness	С	0.10 - 0.25			
Lead Width	b	0.31	-	0.51	
Mold Draft Angle Top	α	5°	_	15°	
Mold Draft Angle Bottom	β	5°	_	15°	

Notes:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. § Significant Characteristic
- Dimension D does not include mold flash, protrusions or gate burrs, which shall not exceed 0.15 mm per end. Dimension E1 does not include interlead flash or protrusion, which shall not exceed 0.25 mm per side.
- 4. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

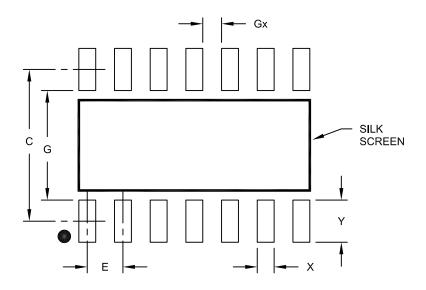
REF: Reference Dimension, usually without tolerance, for information purposes only.

5. Datums A & B to be determined at Datum H.

Microchip Technology Drawing No. C04-065C Sheet 2 of 2

14-Lead Plastic Small Outline (SL) - Narrow, 3.90 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

Units		MILLIMETERS		
Dimension Limits		MIN	NOM	MAX
Contact Pitch	E		1.27 BSC	
Contact Pad Spacing	С		5.40	
Contact Pad Width	Х			0.60
Contact Pad Length	Υ			1.50
Distance Between Pads	Gx	0.67		
Distance Between Pads	G	3.90		·

Notes:

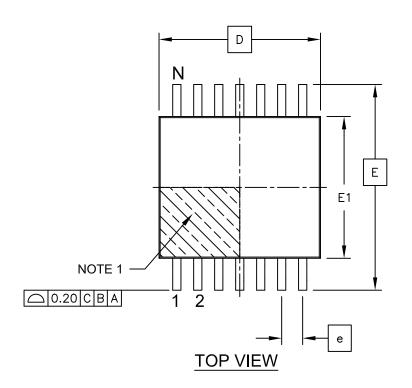
1. Dimensioning and tolerancing per ASME Y14.5M

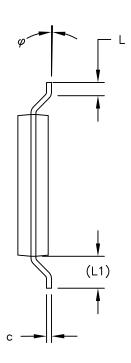
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

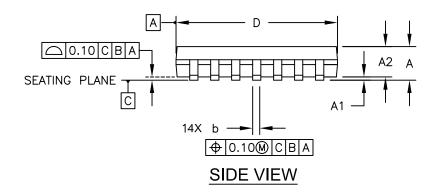
Microchip Technology Drawing No. C04-2065A

14-Lead Plastic Thin Shrink Small Outline (ST) - 4.4 mm Body [TSSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



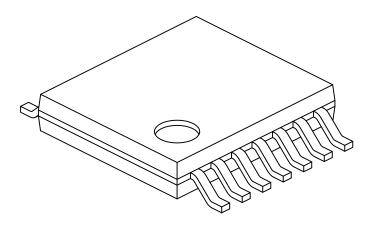




Microchip Technology Drawing C04-087C Sheet 1 of 2

14-Lead Plastic Thin Shrink Small Outline (ST) - 4.4 mm Body [TSSOP]

Ite: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units	MILLIMETERS			
Dimension	Limits	MIN	NOM	MAX	
Number of Pins	N		14		
Pitch	е		0.65 BSC		
Overall Height	Α	=	-	1.20	
Molded Package Thickness	A2	0.80	1.00	1.05	
Standoff	A1	0.05	-	0.15	
Overall Width	E	6.40 BSC			
Molded Package Width	E1	4.30	4.40	4.50	
Molded Package Length	D	4.90	5.00	5.10	
Foot Length	L	0.45	0.60	0.75	
Footprint	(L1)	1.00 REF			
Foot Angle	φ	0°	-	8°	
Lead Thickness	С	0.09	-	0.20	
Lead Width	b	0.19	-	0.30	

Notes:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm per side.
- 3. Dimensioning and tolerancing per ASME Y14.5M

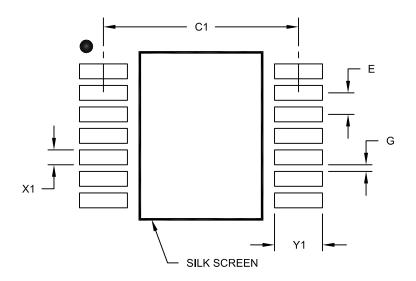
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing No. C04-087C Sheet 2 of 2

14-Lead Plastic Thin Shrink Small Outline (ST) - 4.4 mm Body [TSSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

	Units	MILLIMETERS		
Dimension Limits		MIN	NOM	MAX
Contact Pitch	E		0.65 BSC	
Contact Pad Spacing	C1		5.90	
Contact Pad Width (X14)	X1			0.45
Contact Pad Length (X14)	Y1			1.45
Distance Between Pads	G	0.20		

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2087A

APPENDIX A: REVISION HISTORY

Revision B (August 2013)

The following is the list of modifications:

- Added two new devices to the family: dual version MCP6422 (in 8L-MSOP and 8L-SOIC packages) and quad version MCP6424 (in 15L-SOIC and 14L-TSSOP packages). Added related information throughout the document.
- Updated Package Types drawing with the new devices' pinouts.
- Added ESD Protection on all pins (HBM; MM) (Dual and Quad) in the Section 1.1, Absolute Maximum Ratings †.
- 4. Added the new package temperatures in Table 1-3.
- 5. Updated Figures 2-2 and 2-37 in Section 2.0, Typical Performance Curves. Added new Figure 2-38.
- 6. Updated Section 3.0, Pin Descriptions with pin list and information.
- 7. Added new Section 4.5, Unused Op Amps.
- 8. Updated Section 6.0, Packaging Information with markings and package specification drawings.
- 9. Updated Product Identification System.

Revision A (March 2013)

· Original Release of this Document.

MCP6421/2/4

NOTES:

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

PART NO.	<u>-X</u> / <u>XX</u>	Exa	amples:	
Device Temp Ra		a) b)	MCP6421T-E/LTY: MCP6421T-E/OT:	Tape and Reel, Extended Temperature, 5LD SC-70 package Tape and Reel,
Device:	MCP6421T: Single Op Amp (Tape and Reel) (SC70, SOT-23) MCP6422: Dual Op Amp (MSOP, SOIC)		WIGF04211-E/O1.	Extended Temperature, 5LD SOT-23 package
	MCP6422T: Dual Op Amp (Tape and Reel) (MSOP, SOIC) MCP6424: Quad Op Amp (SOIC, TSSOP)	a)	MCP6422-E/MS:	Extended Temperature, 8LD MSOP package
	MCP6424T: Quad Op Amp (Tape and Reel) (SOIC, TSSOP)	b)	MCP6422T-E/MS:	Tape and Reel, Extended Temperature, 8LD MSOP package
Temperature Range:	E = -40°C to +125°C (Extended)	c)	MCP6422-E/SN:	Extended Temperature, 8LD SOIC package
Package:	LTY* = Plastic Package (SC70), 5-lead MS = Plastic Micro Small Outline Package (MSOP), 8-lead	d)	MCP6422T-E/SN:	Tape and Reel, Extended Temperature, 8LD SOIC package
	OT = Plastic Small Outline Transistor (SOT-23), 5-lead SL = Plastic Small Outline - Narrow, 3.90 mm Body, 14-lead	a)	MCP6424-E/SL:	Extended Temperature, 14LD SOIC package
	SN = Plastic Small Outline - Narrow, 3.90 mm Body, 8-lead	b)	MCP6424T-E/SL:	Tape and Reel, Extended Temperature,
	ST = Plastic Thin Shrink Small Outline - 4.4 mm Body, 14-lead	c)	MCP6424-E/ST:	14LD SOIC package Extended Temperature,
	* Y = Nickel palladium gold manufacturing designator. Only available on the TDFN package.	d)	MCP6424T-E/ST:	14LD TSSOP package Tape and Reel, Extended Temperature, 14LD TSSOP package

MCP6421/2/4

NOTES:

Note the following details of the code protection feature on Microchip devices:

- Microchip products meet the specification contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the intended manner and under normal conditions.
- There are dishonest and possibly illegal methods used to breach the code protection feature. All of these methods, to our
 knowledge, require using the Microchip products in a manner outside the operating specifications contained in Microchip's Data
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- Microchip is willing to work with the customer who is concerned about the integrity of their code.
- Neither Microchip nor any other semiconductor manufacturer can guarantee the security of their code. Code protection does not mean that we are guaranteeing the product as "unbreakable."

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